CellDefectNet: A Machine-designed Attention Condenser Network for Electroluminescence-based Photovoltaic Cell Defect Inspection

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Abstract—Photovoltaic cells are electronic devices that convert light energy to electricity, forming the backbone of solar energy harvesting systems. An essential step in the manufacturing process for photovoltaic cells is visual quality inspection using electroluminescence imaging to identify defects such as cracks, finger interruptions, and broken cells. A big challenge faced by industry in photovoltaic cell visual inspection is the fact that it is currently done manually by human inspectors, which is extremely time consuming, laborious, and prone to human error. While deep learning approaches holds great potential to automating this inspection, the hardware resource-constrained manufacturing scenario makes it challenging for deploying complex deep neural network architectures. In this work, we introduce CellDefectNet, a highly efficient attention condenser network designed via machine-driven design exploration specifically for electroluminescence-based photovoltaic cell defect detection on the edge. We demonstrate the efficacy of CellDefectNet on a benchmark dataset comprising of a diversity of photovoltaic cells captured using electroluminescence imagery, achieving an accuracy of $\sim 86.3\%$ while possessing just 410K parameters ($\sim 13 \times$ lower than EfficientNet-B0, respectively) and $\sim 115M$ FLOPs ($\sim 12 \times$ lower than EfficientNet-B0) and $\sim 13 \times$ faster on an ARM Cortex A-72 embedded processor when compared to EfficientNet-B0.

Index Terms—deep learning, neural network, defect inspection, photovoltaic cell, efficient architecture

I. INTRODUCTION

Photovoltaic cells are electronic devices that convert light energy to electricity, forming the backbone of solar energy harvesting systems. The presence of defects such as interconnect damage, cracks, finger interruptions, material defects, and degraded components can lead to poor power conversion efficiencies and even non-functional cells. As such, an essential step in the manufacturing process is quality inspection to identify such defects.

Deep learning techniques \cite{2, 6, 12, 13} have been showing promising results in different fields and applications. The performance records are being broken by new extensions and improvements everyday. These encouraging results have motivated the development of new high performing deep neural networks and using these techniques to offer new futuristic solutions such as computer vision applications \cite{5, 11, 22}, speech recognition \cite{11, 9} or even for natural language processing tasks \cite{3, 18}. This even motivates researchers in the field of manufacturing to improve the automation including by developing different manufacturing tasks including the inspection systems \cite{7, 8, 14}. However, the development in this this area is still in its infancy because several constraints and limitations need to be taken into account for these types of systems including, i) high efficiency and very fast runtime requirements, ii) high accuracy and robustness of the underlying machine learning model, and iii) the limitation on the number of available training data samples of different defected objects. Building deep neural networks satisfying the aforementioned constraints is time-consuming and usually
impossible for non-expert users and as such using these systems is still cumbersome.

An effective method for photovoltaic cell quality inspection during manufacturing is the use of electroluminescence imaging, where a current is fed into the photovoltaic cell and the radiative recombination of carriers results in luminescence emission. While this technique provides greater contrast and clarity of the defects present in a photovoltaic cell to enable improved visual quality inspection during manufacturing, such a process is still conducted manually by a highly trained operator and as such is highly laborious, very time-consuming, and prone to human error. While deep learning approaches hold great potential to automating this inspection [4], the hardware resource-constrained manufacturing scenario makes it challenging for deploying complex deep neural network architectures.

Here, we introduce CellDefectNet, a highly efficient attention condenser network designed via machine-driven design exploration specifically for electroluminescence-based photovoltaic cell defect detection on the edge. The inspection workflow using CellDefectNet is shown in Figure 1.

II. METHODOLOGY

The concept of Generative Synthesis [23] is utilized to identify the macro- and micro-architecture designs of the proposed CellDefectNet in an automatic approach. The Generative Synthesis process formulates the design exploration by a constrained optimization technique. The optimal network architecture is identified by an optimal generator \( G^*(\cdot) \). The role of generator \( G^*(\cdot) \) is to generate network architectures \( \{N_s | s \in S\} \) maximizing a universal performance function \( U \) [19] and it is found through the constrained optimization process. The optimization process of finding the generator \( G^*(\cdot) \) is subject to a set of constraints:

\[
G^* = \max_{G} U \left( G(s) \right) \quad \text{s.t.} \quad \mathbb{1}_g(G(s)) = 1 \quad \forall s \in S, \quad (1)
\]

where \( S \) is a set of seeds. The operational requirements for the interested network architecture is defined via this set of constraints formulated via an indicator function \( \mathbb{1}_g(\cdot) \): i) the macroarchitecture design uses several parallel columns to significantly reduce the architectural and computational complexity with much greater disentanglement of learned features; ii) to reduce the considerable information loss caused by the pointwise strided convolutions used in residual networks [6] and RegNet architecture [10] here we restricted its use from the optimization; iii) antialiasing downsampling (AADS) [24] modules are to be used in the early network stage to improve network stability and robustness;
iv) FLOPs within 20% of 100M FLOPs for edge compute scenarios. In the machine driven design exploration process, attention condensers (VAC) [20], [21] are used as an highly efficient self-attention module to learn and produce condensed embedding characterizing the joint local and cross-channel activation relationships. However, the machine-driven design exploration process automatically determines the best way to satisfy the defined constraints in designing the CellDefectNet architecture.

A. Network Architecture Design

Figure 2 demonstrates the CellDefectNet network architecture designed via machine driven exploration. The proposed architecture takes advantage of heterogeneous columnar design with a large number of columns, AADS, and early-stage visual attention condensers (VACs) to improve the robustness while providing the proper modeling accuracy. A number of key observations can be made about the generated CellDefectNet architecture:

1) **Early-stage self-attention:** the VACs are leveraged heavily within the initial modules used in the network architecture. VAC was first introduced by Wong et al. [21] for image classification. The VACs can help to better model activation relationships and improves selective attention. However VACs adds a very low complexity to the network compared to other self-attention mechanism. As such, it makes it very attractive for manufacturing use case with real-time processing constraint. Utilizing visual attention condensers in these early stages of the network helps to perform selective focus on important low-to-medium level visual indicators. At the same time it improves the representational efficiency at the very early stages.

2) **Heterogeneous columnar design:** the resulted network architecture by the machine-driven exploration uses a heterogeneous combination of columnar design patterns. The columnar design enforces a great balance between representational power and disentanglement among the representational feature while maintains the network efficiency. This is amplified by using more independent columns in early stage of the network with higher interactions in the later stages. This efficient design is well-suited for manufacturing edge computing scenarios as it reduces the computational complexity in the middle of the network while mandating the representational efficacy of the embedding space.

3) **Anti-aliased design:** the generated CellDefectNet architecture by the machine-driven exploration technique takes advantage of anti-aliased downsampling (AADS) operations across the architecture as well. The AADS modules helps the network architecture to improve robustness and stability. Using AADS modules can across the network serves the purpose of conventional pooling operation while account for greater representational efficacy.

A. Experimental Setup

To explore the efficacy of the proposed CellDefectNet, we evaluated its performance on a benchmark dataset comprising of a diversity of photovoltaic cells captured using electroluminescence imagery [4]. The benchmark dataset comprises of 2624 images captured of monocrystalline and polycrystalline photovoltaic cells with 1100 defective samples and 1514 non-defective samples, with a training/test split of 75%/25% as described in [8]. The resolution of the images are 300 × 300.

Figure 3 demonstrates samples from the benchmark dataset and different possible defects. As seen, it is very difficult to distinguish between the defect-free (functional) and defective samples without having expert knowledge to identify them.

B. Competing Methods

In addition to evaluating the performance of CellDefectNet, we also tested on the VGG-19 [15] network architecture on the same benchmark for reference purposes given that it was used as a backbone for photovoltaic defect detection in [4], and we also evaluated two state-of-the-art efficient architectures: EfficientNet-B0 [17] and MnasNet [16]. As described in [4], the network architectures were first trained using Adam optimization on only the fully-connected layers for 100 epochs with a learning rate of $1.0 \times 10^{-3}$, then trained with stochastic gradient descent optimization on the entire network for 100 epochs with a learning rate of $5.0 \times 10^{-4}$ and batch size of 16.

C. Performance Metrics and Results

The competing models are evaluated based on their quantitative performance, architectural complexity, computational complexity, and inference speed. For quantitative performance, we compute the test accuracy as the key metric. For architectural complexity, we assess the number of parameters in the neural network architecture as the key metric. For computational complexity, we measure the number of floating point operations (FLOPs) as the key metric. Finally, for inference speed, we measure the run-time latency on an ARM Cortex A-72 64-bit 1.5GHz processor as the key metric. The comparative results for the proposed CellDefectNet and several state-of-the-art efficient architectures are illustrated in Table I.

D. Architectural Complexity

First, from an architectural complexity perspective, CellDefectNet consists of just $\sim410K$ parameters, which is significantly smaller than all the competing state-of-the-art efficient architectures. More specifically, CellDefectNet is $\sim341.46\times$ smaller compared to the VGG-19 architecture while achieving 1.2% higher accuracy. CellDefectNet is $\sim13\times$ smaller compared to the highly efficient EfficientNet-B0 (the most accurate architecture outside of CellDefectNet) while achieving $\sim0.9\%$ higher accuracy. Furthermore, CellDefectNet is $\sim9.5\times$ smaller compared to the highly efficient MnasNet (the most efficient architecture outside of CellDefectNet) while achieving $\sim2.6\%$ higher accuracy.
Fig. 3. Image samples of the benchmark dataset of photovoltaic cells captured using electroluminescence imagery. The images are from two different types of solar cells including, Monocrystalline and Polycrystalline. As seen, it is very difficult to distinguish between the functional and defective samples from both types of solar cells.

<table>
<thead>
<tr>
<th>Model</th>
<th>Test Acc (%)</th>
<th>Param (M)</th>
<th>FLOPs (M)</th>
<th>Run-time (s)</th>
</tr>
</thead>
<tbody>
<tr>
<td>VGG-19</td>
<td>85.06</td>
<td>140</td>
<td>34570</td>
<td>10.893</td>
</tr>
<tr>
<td>EfficientNet-B0</td>
<td>85.37</td>
<td>5.3</td>
<td>1397</td>
<td>4.479</td>
</tr>
<tr>
<td>MnasNet</td>
<td>83.69</td>
<td>3.9</td>
<td>1074</td>
<td>3.746</td>
</tr>
<tr>
<td>CellDefectNet</td>
<td>86.28</td>
<td>0.41</td>
<td>115</td>
<td>0.347</td>
</tr>
</tbody>
</table>
E. Computational Complexity

Second, in terms of computational complexity, CellDefectNet requires only \( \sim 115 \text{M FLOPs} \) which is significantly lower than VGG-19 as well as the tested state-of-the-art efficient architectures. More specifically, CellDefectNet requires \( \sim 300 \times \) fewer FLOPs compared to the VGG-19 architecture, \( \sim 12.14 \times \) fewer FLOPs compared to EfficientNet-B0, and \( \sim 9.34 \times \) fewer FLOPs compared to MnasNet.

F. Accuracy

Third, from an accuracy perspective, CellDefectNet achieved the highest accuracy amongst the tested architectures at a test accuracy of 86.28%. These results illustrate the strong balance achieved by CellDefectNet in terms of accuracy, architectural complexity, and computational complexity, making it very well-suited for high-performance Photovoltaic cells defect detection in resource-constrained manufacturing environments.

G. Embedded inference speed

We further explore real-world operational efficiency of the proposed CellDefectNet architecture in embedded scenarios by evaluating its run-time latency (at a batch size of 1) on an ARM Cortex A-72 64-bit 1.5GHz processor in comparison with the other tested architectures in this study. It can be seen from Table I that the proposed CellDefectNet architecture is able to achieve a runtime latency of 0.347 s per sample, which is significantly lower than that of VGG-19 along with the tested state-of-the-art efficient deep neural network architectures explored in this study. More specifically, the proposed CellDefectNet is \( 31.39 \times \) faster when compared to the VGG-19 architecture, \( \sim 13 \times \) faster when compared to the EfficientNet-B0 architecture, and \( \sim 10.8 \times \) faster when compared to the MnasNet architecture (the fastest architecture running on the ARM embedded processor outside of CellDefectNet). The significant speed advantages of CellDefectNet make it very well-suited for use on embedded edge computer devices for high-throughput manufacturing scenarios. Furthermore, the significantly lower architectural and computational complexity as well as higher accuracy achieved by the proposed CellDefectNet network architecture illustrates the effectiveness of leveraging a machine-driven design exploration strategy with both computational as well as “best-practices” constraints in the creation of highly tailored deep neural network architectures that are designed and customized in an automatic fashion for a specific industry task and scenario at hand and on the edge.

IV. Conclusions

Here, we took advantage a machine-driven design exploration with computational and “best-practices” to build a highly compact deep neural network architectures for the task of photovoltaic cell defect detection. The resulting network architecture, so-called CellDefectNet, contains a unique self-attention network architecture with highly usage of heterogeneous columnar macro-architecture design, antialiasing properties, and highly tailored microarchitecture design to strongly balance between accuracy, robustness, and efficiency for the real-world manufacturing use cases. Experimental results shows that the proposed CellDefectNet is able to achieve a detection accuracy of \( \sim 86.2\% \) on the photovoltaic cells captured using electroluminescence imagery benchmark with highly efficient architectural and very lower computational complexity when compared to state-of-the-art efficient deep neural network architectures. Furthermore, the run-time experiments demonstrates that the proposed CellDefectNet achieves significantly faster inference speed on an embedded ARM processor with \( 31.39 \times \) speed-up compared to the state-of-the-art model for this purpose, a very well-suited machine learning model for photovoltaic cell defect detection in high-throughput, resource-constrained manufacturing scenarios. The future works aims to explore and leveraging of this machine-driven design exploration strategy to build even more efficient architecture for this problem and also produce highly efficient yet high-performing deep neural network architectures for other critical manufacturing applications with using different sensing modalities such as acoustic sensors for predictive maintenance.

References


